


<b>Search Notes</b> 	<b>Application/Control No.</b> 10824374	<b>Applicant(s)/Patent Under Reexamination</b> UCHIDA, YUICHIRO
	<b>Examiner</b> Leff, Steven	<b>Art Unit</b> 1761

SEARCHED			
Class	Subclass	Date	Examiner
426	107, 126, 234, 412, 524,	2/8/2007	
a23L	01/01	2/12/2007	

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner